

SIM CARD CONNECTOR Frame WITH PIVOT ARM

1.0 SCOPE

This Product Specification covers the performance requirements of the SIM Card Connector frame and the SIM Card Connector (Block SIM).

(This part is a frame only, it must be used together with Molex 0.35mm block SIM 151032 for an entire SIM pop out system)

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBER(S)

Product Name	Series Number
SIM CONNECTOR FRAME, WITH DETECT PIN SIM CONNECTOR TRAY SIM CARD CONNECTOR (BLOCK SIM)	151031 151031 151032

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See Sales Drawing SD-151031-0001 and SD-151032-0001 for information on dimensions, materials, platings and markings.

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 CREATED / REVISED BY:
 CHECKED BY:
 APPROVED BY:

 PS-151031-0001 Jzeng
 JTAN
 KHLIM

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3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

The following documents form a part of this specification to the extended specified herewith. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence.

4.0 RATINGS

4.1 CURRENT RATING

0.5Amps Max. per contact

4.2 VOLTAGE RATING 10 Volt DC Max.

4.3 TEMPERATURE Operating:

- 30°C to + 85°C

5.0 MECHANICAL INTERFACE

5.1 CARD INTERFACE

SIM card interface: GSM 11.11 specification

5.2 PWB INTERFACE

Plating on PWB pads: OSP plated

6.0 PERFORMANCE

6.1 ELECTRICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
1	Low Level Contact Resistance (LLCR)	 Mate connectors with dry circuit (20 mV, 100mA MAX) on mated connector. Between Detect Spring and Detect Contact Shell (Refer to appendix 1) (EIA-364-23C) 	Block sim terminal and sim card: 50 milliohm [MAXIMUM] Detect pin and detect contact shell: 100 milliohm [MAXIMUM] No mechanical damage
2	Insulation Resistance	Unmated connectors Apply a voltage of 100 V DC between adjacent terminals. Electrification Time: 1 min (EIA-364-21D)	1000 Megohms [MINIMUM] No mechanical damage

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PRODUCT SPECIFICATION

3	Dielectric Withstanding Voltage	Unmated connectors: apply a voltage of 500 VAC between adjacent contact for 1 minutes (EIA-364-20C)	No voltage breakdown No mechanical damage
4	Temperature Rise	Mated and measure the temperature rise of contact, when rated current is passed. (IEC 60512-5-1)	Temperature Rise 30°C [MAXIMUM] No mechanical damage

6.2 MECHANICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
5	Contact Normal Force	Measure contact normal force at 0.14mm away from housing top surface and at maximum deflection (0mm from housing) (refer to Appendix 2) Note : a) All forces to be measured at returned curve. b) Force to be taken after 5X cycle mate and unmate	1. 0.30N min at 0.14mm away from housing top surface No mechanical damage
6	Tray Insertion and Withdrawal (direct pull out tray) (with Card)	Insert the card at a speed rate of 12.5+/- 3mm/min (EIA 364-13D) Withdraw the card at a speed rate of 12.5+/-3mm/min (EIA 364-13D)	Insertion Force: 15N Max Withdrawal Force: 3N Min No mechanical damage
7	Durability (Horizontal Insertion Direction-machine)	Mate and unmate connectors to 3000cycles at a maximum rate of 720cycles/hour. Take LLCR readings at 3000 th cycle (Refer to appendix 3.) (EIA-364-09C)	Terminal Contact resistance 50 milliohms [MAXIMUM] Detect pin and detect contact shell: 100 milliohm [MAXIMUM] No mechanical damage
8	Solder Joint Peeling Strength	Apply a load to the connector frame parallel to the PWB (X & Y direction) (refer to Appendix 4)	50N min

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m		9	PRODUCT SPECIFIC	CATION
	9	Solderability	Solder paste is deposited on a ceramic plate via stencil. The connectors are steam aged and placed onto the solder paste print. The substrate is processed through a forced hot convection oven. Refer to section 9.0 for temp profile. The connectors are removed from the ceramic and inspected. Steam Aging: 8 hour (ANSI-J-STD 002)	Solder coverage = 95% [MINIMUM] No mechanical damage
	10	Vibration (Sine)	Sine Vibration, 10g peak Frequency: 10~500Hz, 2 cycles per axis 15 mins per cycle (EIA 364-28F) – Test Condition II	Contact resistance 50 milliohms [MAXIMUM] Detect pin and detect contact shell: 100 milliohm [MAXIMUM] Discontinuity < 1 μs
	11	Mechanical Shock	Pulse shape = half sine Peak acceleration = 490m/s2 (50G) Duration of pulse = 11ms	

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ITEM	DESCRIPTION	TEST CONDITION		REQU	IREMENT
12	high Temperature Exposure	Expose connector to on test condition of: 85 ⁰ C for 96 hours, then reco	Check Contact resist Check Contact resist Terminal: 50 mill [MAXIMUM] C for 96 hours, then recover 2 hours at bient atmosphere; Check mechanical and		
13	Low Temperature Exposure	Expose connector to on test condition of: -40 ^o C for 96 hours, then reco ambient atmosphere; Check electrical performance	over 2 hours at	Check Contact resistance Terminal: 50 milliohm [MAXIMUM] Detect pin: 100 millioh [MAXIMUM] No mechanical damage	
14	Thermal Shock	condition for 25 cycles (60 mins/cycle): 40 °C (30 min) ← → 85 °C (30 min) Transit time shall be within 5 mins (Max) Check Cont Terminal: [MAX] Detect pi conta		nical damage, and oxidation at act area tact resistance: 50 milliohms XIMUM] in and detect act shell: m [MAXIMUM]	
15	Cyclic Humidity	Cycle the part between 25° 80%+/-3%RH and 65°C+/-3 3%RH Ramp times should be 30mi times to be 1hour. Dwell tim temp and humidity have sta specified levels. Perform 24	°C at 50%+/- ins and dwell les start when bilized within the	Contact resistance 50 milliohms [MAXIMUM] Insulation resistance 1000 Megohms [MINIMUM]	
16	Salt Spray	Expose the mated connecto salt mist condition: Concentration : 5±1% Temperature : 35±2°C Test time : 48h Note: Remove the salt depo wash or dip in running water natural drying under room te	Expose the mated connectors to the following salt mist condition: Concentration : 5±1% Temperature : 35±2°C Test time : 48h Note: Remove the salt deposits by a gentle wash or dip in running water, follow by natural drying under room temperature for 2 hours before the measurement		: 50 milliohms XIMUM] : 100 milliohms
17	Resistance to Soldering Condition				
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7.0 PACKAGING

7.1 Frame (151031)

Parts shall be packaged to protect against damage during handling, transit and storage. The parts shall be carried in reels inside boxes. For details, kindly refer to Packaging spec PK-151031-xxxx and Sale drawing SD-151031-xxxx.

7.2 Block SIM (151032)

Parts shall be packaged to protect against damage during handling, transit and storage. The parts shall be carried in reels inside boxes. For details, kindly refer to Packaging spec PK-151032-xxxx and Sale drawing SD-151032-xxxx

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					Test (Group			
测试项目	A (screen	B (screen	C (screen	D	Е	F	G	Н	Ι
Examination of connector(s) Normal Force Insertion/Withdrawal Force Durability (machine) Solder Joint Peeling Force Solderability Vibration (Sine)	test)	test)	test)						
	1	1	1		1	1	1		1
	6	8	1 3	1	7	10	1 9	1	1 3
Normal Force	3 5								
		4 6							
Durability (machine)	4	5				4			
Solder Joint Peeling Force				3					
Solderability			2						
Vibration (Sine)					5				
Mechanical Shock					4				
LLCR		3 7			3 6	3 5 7 9		3 5	
Insulation Resistance							3 7		
Dielectric Withstanding Voltage							4 8		
Temperature Rise									2
High Temperature Exposure									
Low Temperature Exposure									
Thermal Shock						6	5		
Cyclic Humidity						8	6		
Salt spray								4	
Resistance to Soldering Conditions	2	2	2	2	2	2	2	2	
Sample Size	5	5	5	5	5	5	5	5	5

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9.0 SOLDERING PROFILE





